

IN THE CLAIMS

1. (Currently amended) A method for rapidly controlling the rate of ion generation in an ion source having a filament-cathode and a mirror electrode, the ion source being operable to generate an ion beam from the ionization of an ion precursor gas present in ~~the~~a chamber by electrons emitted from the filament-cathode, the method comprising the steps of:
- 5 supplying current to said filament-cathode;  
supplying current to said mirror electrode; and  
controlling the potential difference between said filament-cathode and said mirror electrode by modifying the potential of the mirror electrode to control the number of electrons available for ionization.
- 10 2. (Currently amended) The method of claim 1 further comprising the step of reducing ~~the~~an ion beam intensity by driving the potential of the mirror electrode positive relative to the filament-cathode.
- 15 3. (Currently amended) The method of claim 1 further comprising the step of increasing ~~the~~an ion beam intensity by driving the potential of the mirror electrode to ~~negatively~~ negative bias ~~the mirror electrode~~ relative to the filament-cathode of the ion chamber.
- 20 4. (Currently amended) The method of claim 1 wherein the filament-cathode is a directly heated filament-cathode.
5. (Currently amended) The method of claim 1 wherein the filament-cathode is an indirectly heated filament-cathode.
6. (Original) The method of claim 1 further comprising the step of modulating the number of electrons in a manner that varies the ion beam from a first intensity to a second intensity during a time frame of less than one millisecond.
- 25 7. (Currently amended) A method for rapidly controlling the rate of ion generation in an ion source having a filament-cathode, a mirror electrode, and at least one grid, the ion source being operable to generate an ion beam from the ionization

of an ion precursor gas present in ~~the~~a chamber by electrons emitted from the filament-cathode, the method comprising the steps of:

supplying current to said filament-cathode;

supplying current to said mirror electrode;

5 supplying current to the grid, and

controlling the potential difference between said filament-cathode and said grid by modifying the potential of the grid relative to the filament-cathode to control the number of electrons available for ionization between the grid and the mirror electrode.

10 8. (Currently amended) The method of claim 7 further comprising the step of reducing ~~the~~an ion beam intensity by driving the potential of the grid positive relative to the filament-cathode.

9. (Currently amended) The method of claim 7 further comprising the step of increasing ~~the~~an ion beam intensity by driving the potential of the grid to  
15 negatively bias the grid relative to the filament-cathode.

10. (Currently amended) The method of claim 7 wherein the filament-cathode is a directly heated filament-cathode.

11. (Currently amended) The method of claim 7 wherein the filament-cathode is an indirectly heated filament-cathode.

20 12. (Original) The method of claim 7 further comprising the step of modulating the number of electrons in a manner that varies the ion beam from a first intensity to a second intensity during a time frame of less than one millisecond.

13. (Currently amended) An improved ion source apparatus for rapidly modulating ~~the~~an intensity of an ion beam, comprising:

25 an ion chamber having mutually opposed sides and configured to receive an ion precursor gas;

a filament-cathode located on one side of said ion chamber and operable to emit electrons for ~~the~~ ionization of the ion precursor gas for ~~the~~ generation of the ion beam; and

a mirror electrode having a potential associated therewith and located on the other side of said ion chamber, said mirror electrode being connected to a circuit to vary its potential -relative to said filament-cathode so as to vary the number of the electrons available in the ion chamber for ionization.

14. (Currently amended) The apparatus of claim 13 wherein said mirror electrode is operable for modulating the ion beam ~~between~~from a first intensity to a ~~and~~-second intensity during a time frame of less than 1 millisecond.

15. (Currently amended) The apparatus of claim 13 wherein the filament-  
10 cathode is a directly heated filament-cathode.

16. (Currently amended) The apparatus of claim 13 wherein the filament-cathode is an indirectly heated filament-cathode.

17. (Currently amended) An improved ion source apparatus for rapidly modulating ~~the~~an intensity of an ion beam, comprising:  
15 an ion chamber having mutually opposed sides and configured to receive an ion precursor gas;  
a filament-cathode located on one side of said ion chamber and operable to emit electrons for ~~the~~-ionization of the ion precursor gas for ~~the~~ generation of the ion beam;  
20 a mirror electrode located on the other side of said ion chamber, and at least one grid extending inside said ion chamber and positioned between said filament-cathode and said mirror electrode, said at least one grid being connected to a circuit to vary its potential relative to said filament-cathode and being operable so as to vary the number of  
25 electrons available in the ion chamber for ionization.

18. (Currently amended) The apparatus of claim 17 wherein the filament-cathode is a directly heated filament-cathode.

19. (Currently amended) The apparatus of claim 17 wherein the filament-cathode is an indirectly heated filament-cathode.

20. (Currently amended) The apparatus of claim 17 wherein said at least one grid is positioned in proximity to said filament-cathode so as to vary the number of electrons available for ionization between said at least one grid and said mirror electrode.